

Symbol	Tr1:Nch	Tr2:Pch
$V_{DSS}$	100V	-100V
$R_{DS(on)}(Max.)$	325m $\Omega$	470m $\Omega$
$I_D$	$\pm 2A$	$\pm 1.5A$
$P_D$	1.5W	

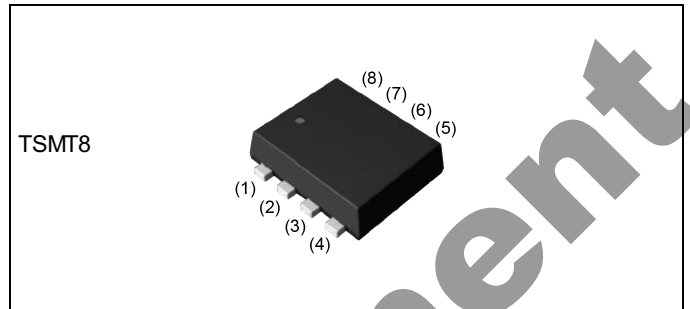
#### ●Features

- 1) Low on - resistance
- 2) Small Surface Mount Package (TSMT8)
- 3) Pb-free lead plating ; RoHS compliant
- 4) AEC-Q101 Qualified

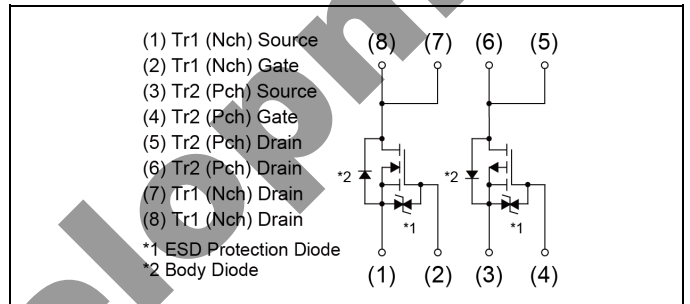
#### ●Application

Switching

#### ●Outline



#### ●Inner circuit



#### ●Packaging specifications

Type	Packing	Embossed Tape
	Reel size (mm)	180
	Tape width (mm)	8
	Basic ordering unit (pcs)	3000
	Taping code	TR
	Marking	M51

#### ●Absolute maximum ratings ( $T_a = 25^\circ C$ ,unless otherwise specified)

Parameter	Symbol	Value		Unit
		Tr1:Nch	Tr2:Pch	
Drain - Source voltage	$V_{DSS}$	100	-100	V
Continuous drain current	$I_D$	$\pm 2$	$\pm 1.5$	A
Pulsed drain current	$I_{DP}^{*1}$	$\pm 6$	$\pm 6$	A
Gate - Source voltage	$V_{GSS}$	$\pm 20$	$\pm 20$	V
Power dissipation	total	$P_D^{*2}$	1.5	W
		$P_D^{*3}$	1.1	
Junction temperature	$T_j$	150	$^\circ C$	
Operating junction and storage temperature range	$T_{stg}$	-55 to +150	$^\circ C$	

● Thermal resistance

Parameter	Symbol	Values			Unit	
		Min.	Typ.	Max.		
Thermal resistance, junction - ambient	total	$R_{thJA}^{*2}$	-	-	83.3	°C/W
		$R_{thJA}^{*3}$	-	-	113	

● Electrical characteristics (T<sub>a</sub> = 25°C)

Parameter	Symbol	Type	Conditions	Values			Unit
				Min.	Typ.	Max.	
Drain - Source breakdown voltage	$V_{(BR)DSS}$	Tr1	$V_{GS} = 0V, I_D = 1mA$	100	-	-	V
		Tr2	$V_{GS} = 0V, I_D = -1mA$	-100	-	-	
Breakdown voltage temperature coefficient	$\frac{\Delta V_{(BR)DSS}}{\Delta T_j}$	Tr1	$I_D = 1mA$ , referenced to 25°C	-	116.9	-	mV/°C
		Tr2	$I_D = -1mA$ , referenced to 25°C	-	-91.3	-	
Zero gate voltage drain current	$I_{DSS}$	Tr1	$V_{DS} = 100V, V_{GS} = 0V$	-	-	1	μA
		Tr2	$V_{DS} = -100V, V_{GS} = 0V$	-	-	-1	
Gate - Source leakage current	$I_{GSS}$	Tr1	$V_{GS} = \pm 20V, V_{DS} = 0V$	-	-	±10	μA
		Tr2	$V_{GS} = \pm 20V, V_{DS} = 0V$	-	-	±10	
Gate threshold voltage	$V_{GS(th)}$	Tr1	$V_{DS} = 10V, I_D = 1mA$	1.0	-	2.5	V
		Tr2	$V_{DS} = -10V, I_D = -1mA$	-1.0	-	-2.5	
Gate threshold voltage temperature coefficient	$\frac{\Delta V_{GS(th)}}{\Delta T_j}$	Tr1	$I_D = 1mA$ , referenced to 25°C	-	-3.6	-	mV/°C
		Tr2	$I_D = -1mA$ , referenced to 25°C	-	3.0	-	
Static drain - source on - state resistance	$R_{DS(on)}^{*4}$	Tr1	$V_{GS} = 10V, I_D = 2A$	-	240	325	mΩ
			$V_{GS} = 4.5V, I_D = 2A$	-	250	340	
			$V_{GS} = 4.0V, I_D = 2A$	-	260	355	
		Tr2	$V_{GS} = -10V, I_D = -1.5A$	-	350	470	
			$V_{GS} = -4.5V, I_D = -0.75A$	-	380	510	
			$V_{GS} = -4.0V, I_D = -0.75A$	-	400	540	
Gate resistance	$R_G$	Tr1	f=1MHz, open drain	-	8.5	-	Ω
		Tr2		-	8.2	-	
Forward Transfer Admittance	$ Y_{fs} ^{*4}$	Tr1	$V_{DS} = 10V, I_D = 2A$	1.9	-	-	S
		Tr2	$V_{DS} = -10V, I_D = -1.5A$	1.5	-	-	

\*1 Pw ≤ 10μs, Duty cycle ≤ 1%

\*2 Mounted on a ceramic board (30×30×0.8mm)

\*3 Mounted on a FR4 (25×25×0.8mm)

\*4 Pulsed

●Electrical characteristics (T<sub>a</sub> = 25°C)

<Tr1>

Parameter	Symbol	Conditions	Values			Unit
			Min.	Typ.	Max.	
Input capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0V	-	290	-	pF
Output capacitance	C <sub>oss</sub>	V <sub>DS</sub> = 25V	-	30	-	
Reverse transfer capacitance	C <sub>rss</sub>	f = 1MHz	-	20	-	
Turn - on delay time	t <sub>d(on)</sub> <sup>*4</sup>	V <sub>DD</sub> ≈ 50V, V <sub>GS</sub> = 10V	-	10	-	ns
Rise time	t <sub>r</sub> <sup>*4</sup>	I <sub>D</sub> = 1A	-	10	-	
Turn - off delay time	t <sub>d(off)</sub> <sup>*4</sup>	R <sub>L</sub> = 50Ω	-	30	-	
Fall time	t <sub>f</sub> <sup>*4</sup>	R <sub>G</sub> = 10Ω	-	15	-	

<Tr2>

Parameter	Symbol	Conditions	Values			Unit
			Min.	Typ.	Max.	
Input capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0V	-	950	-	pF
Output capacitance	C <sub>oss</sub>	V <sub>DS</sub> = -25V	-	45	-	
Reverse transfer capacitance	C <sub>rss</sub>	f = 1MHz	-	20	-	
Turn - on delay time	t <sub>d(on)</sub> <sup>*4</sup>	V <sub>DD</sub> ≈ -50V, V <sub>GS</sub> = -10V	-	10	-	ns
Rise time	t <sub>r</sub> <sup>*4</sup>	I <sub>D</sub> = -075A	-	15	-	
Turn - off delay time	t <sub>d(off)</sub> <sup>*4</sup>	R <sub>L</sub> = 66Ω	-	60	-	
Fall time	t <sub>f</sub> <sup>*4</sup>	R <sub>G</sub> = 10Ω	-	10	-	

● Gate charge characteristics ( $T_a = 25^\circ\text{C}$ )

<Tr1>

Parameter	Symbol	Conditions	Values			Unit
			Min.	Typ.	Max.	
Total gate charge	$Q_g^{*4}$	$V_{DD} \approx 50\text{V}, I_D = 2\text{A}$ $V_{GS} = 5\text{V}$	-	4.7	-	nC
Gate - Source charge	$Q_{gs}^{*4}$		-	1.2	-	
Gate - Drain charge	$Q_{gd}^{*4}$		-	1.8	-	

<Tr2>

Parameter	Symbol	Conditions	Values			Unit
			Min.	Typ.	Max.	
Total gate charge	$Q_g^{*4}$	$V_{DD} \approx -50\text{V}, I_D = -1.5\text{A}$ $V_{GS} = -5\text{V}$	-	17.0	-	nC
Gate - Source charge	$Q_{gs}^{*4}$		-	4.5	-	
Gate - Drain charge	$Q_{gd}^{*4}$		-	5.0	-	

● Body diode electrical characteristics (Source-Drain) ( $T_a = 25^\circ\text{C}$ )

<Tr1>

Parameter	Symbol	Conditions	Values			Unit
			Min.	Typ.	Max.	
Continuous forward current	$I_S$	$T_a = 25^\circ\text{C}$	-	-	1.0	A
Pulse forward current	$I_{SP}^{*1}$		-	-	6	
Forward voltage	$V_{SD}^{*4}$	$V_{GS} = 0\text{V}, I_S = 2\text{A}$	-	-	1.2	V

<Tr2>

Parameter	Symbol	Conditions	Values			Unit
			Min.	Typ.	Max.	
Continuous forward current	$I_S$	$T_a = 25^\circ\text{C}$	-	-	-1.0	A
Pulse forward current	$I_{SP}^{*1}$		-	-	-6	
Forward voltage	$V_{SD}^{*4}$	$V_{GS} = 0\text{V}, I_S = -0.75\text{A}$	-	-	-1.2	V

● Electrical characteristic curves <Tr1>

Fig.1 Power Dissipation Derating Curve

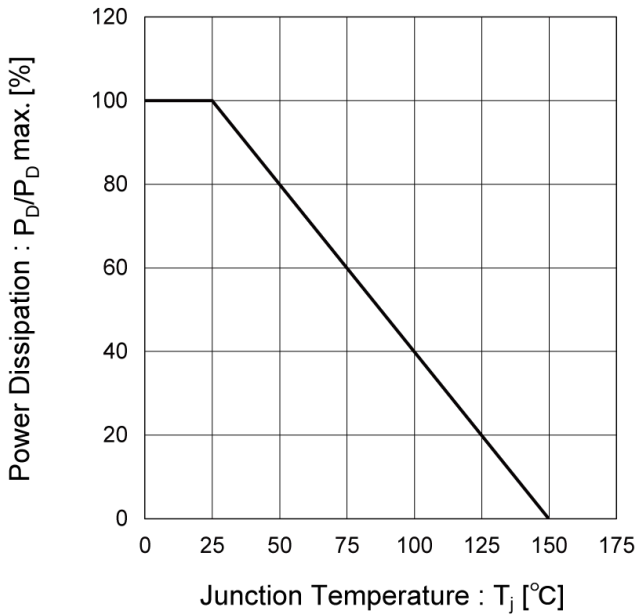


Fig.2 Maximum Safe Operating Area

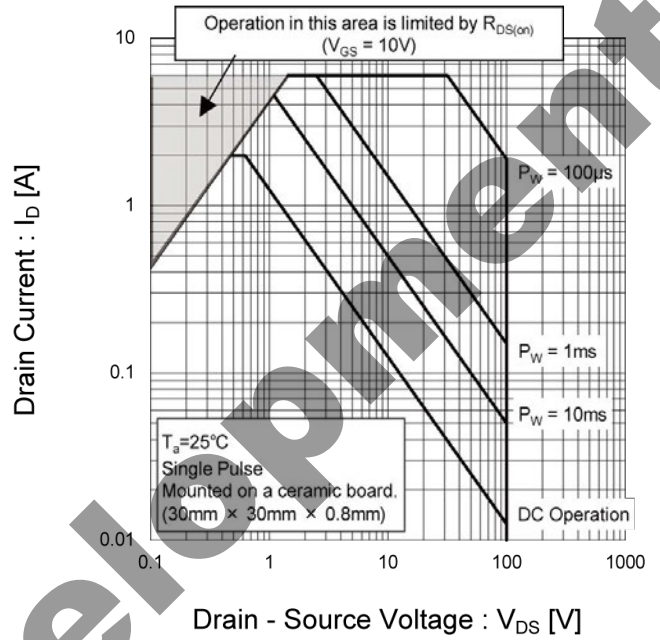


Fig.3 Normalized Transient Thermal Resistance vs. Pulse Width

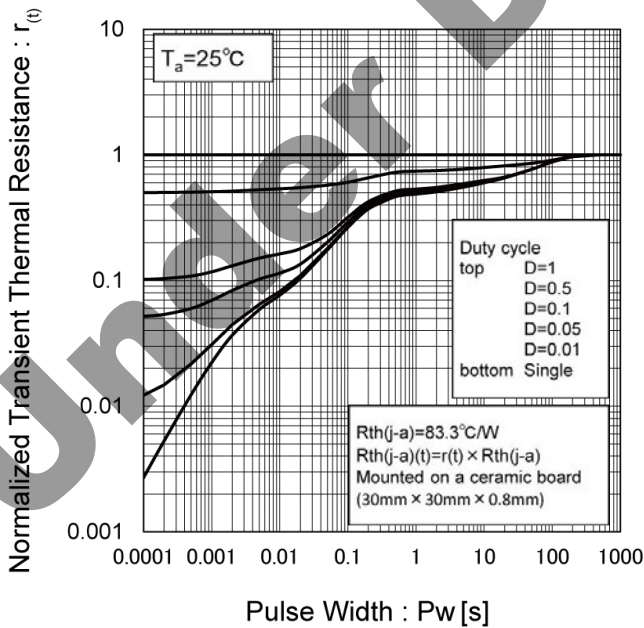
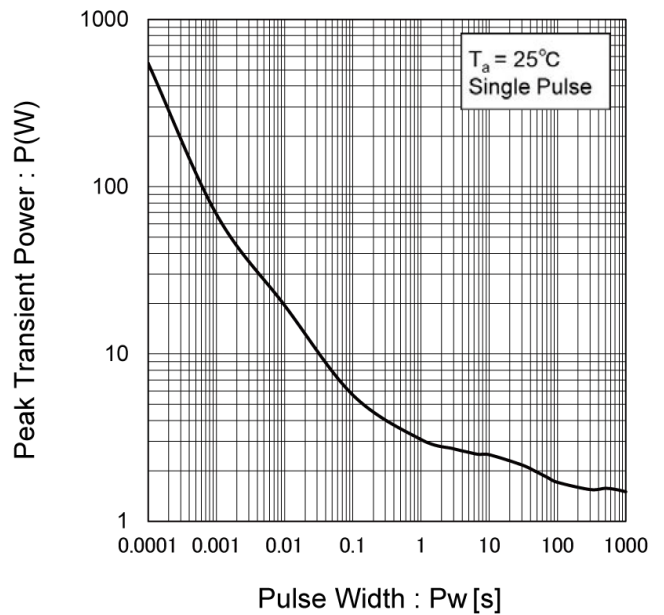


Fig.4 Single Pulse Maximum Power dissipation



●Electrical characteristic curves <Tr1>

Fig.5 Typical Output Characteristics(I)

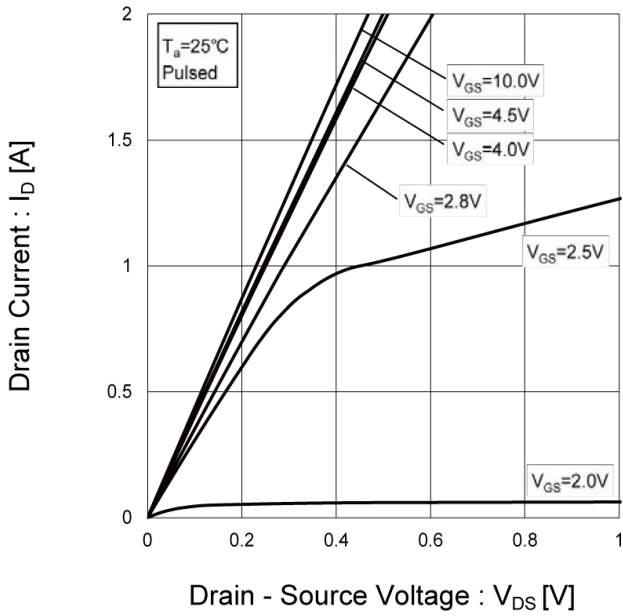


Fig.6 Typical Output Characteristics(II)

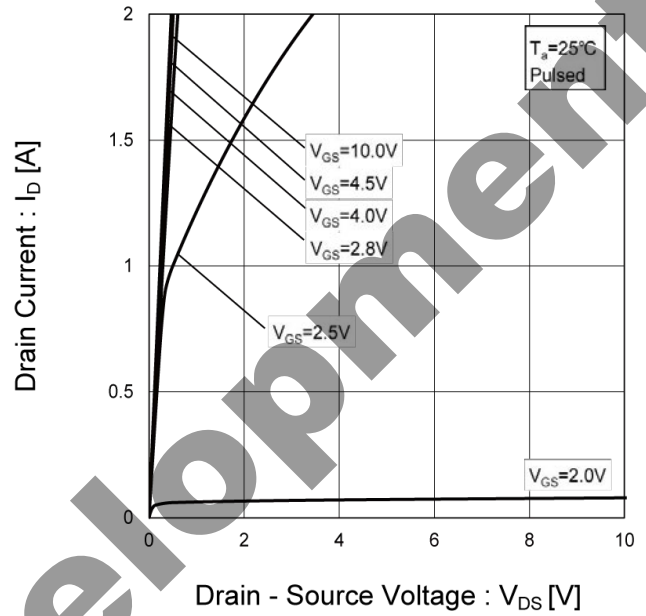
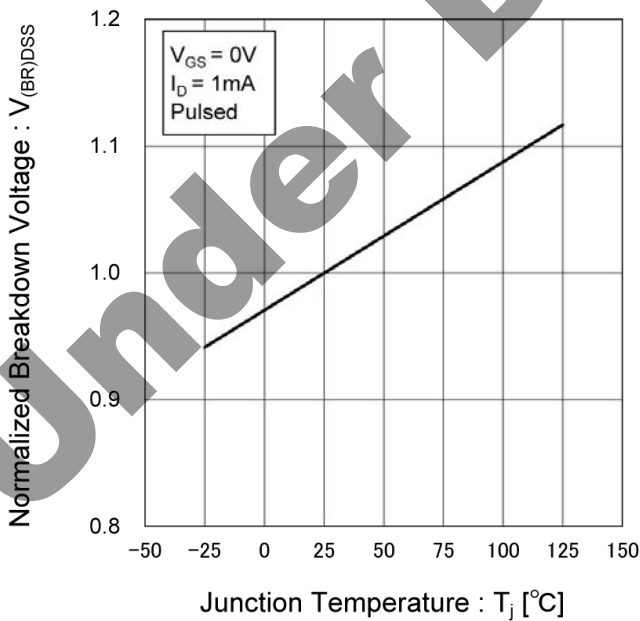


Fig.7 Breakdown Voltage vs. Junction Temperature



●Electrical characteristic curves <Tr1>

Fig.8 Typical Transfer Characteristics

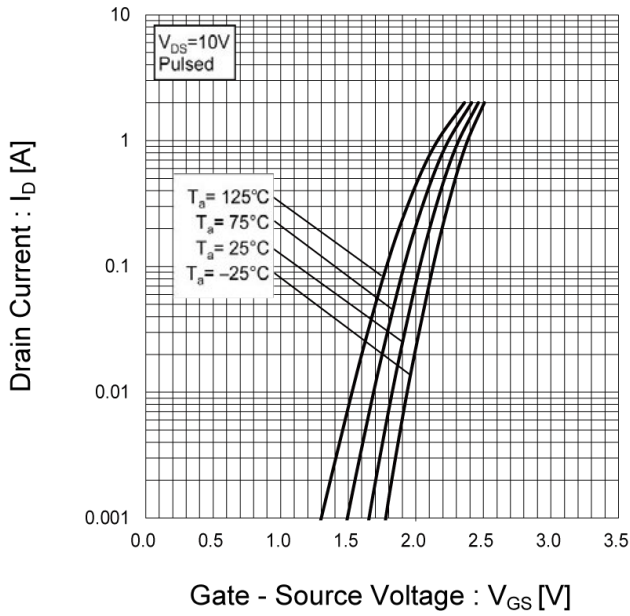


Fig.9 Gate Threshold Voltage vs. Junction Temperature

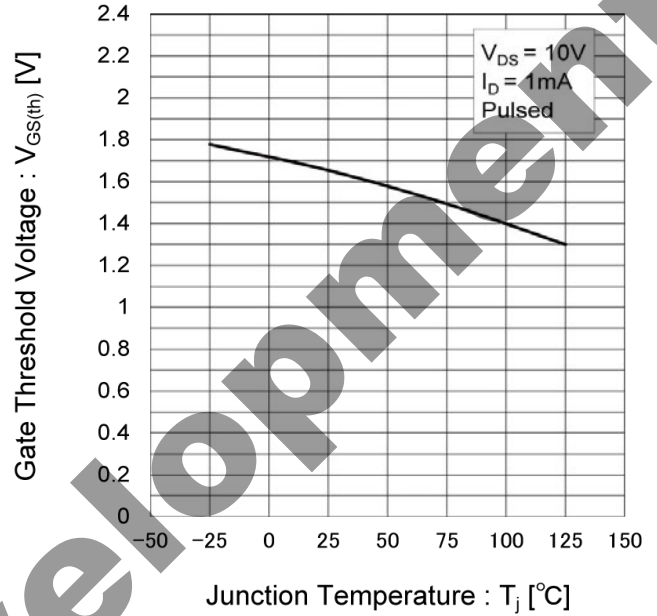
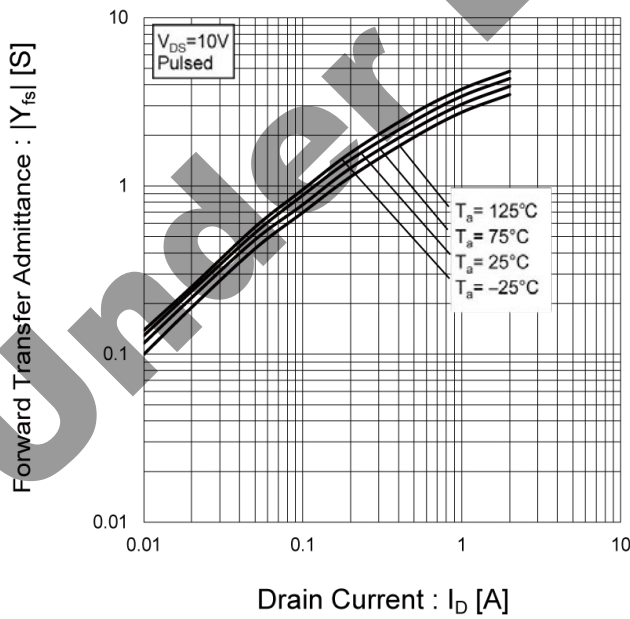


Fig.10 Forward Transfer Admittance vs. Drain Current



●Electrical characteristic curves <Tr1>

Fig.11 Drain Current Derating Curve

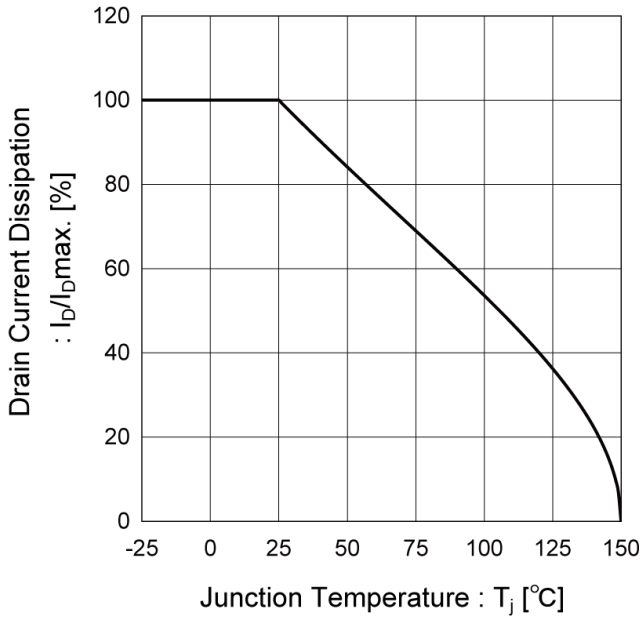


Fig.12 Static Drain - Source On - State Resistance vs. Gate Source Voltage

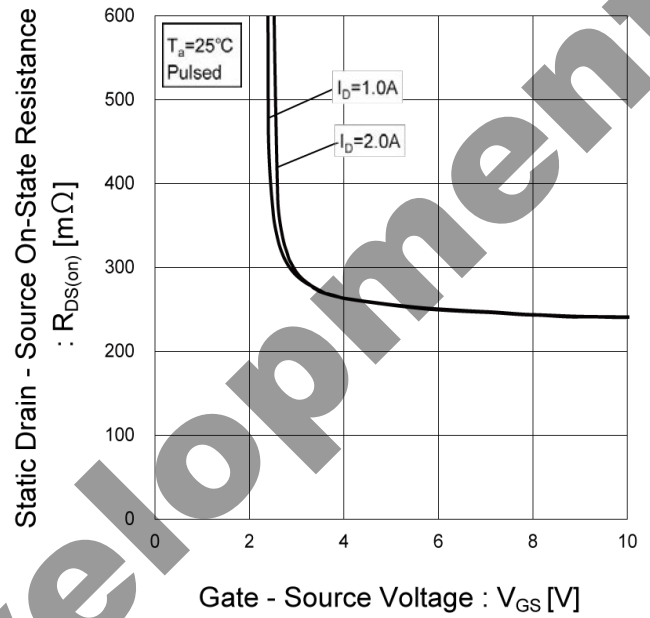
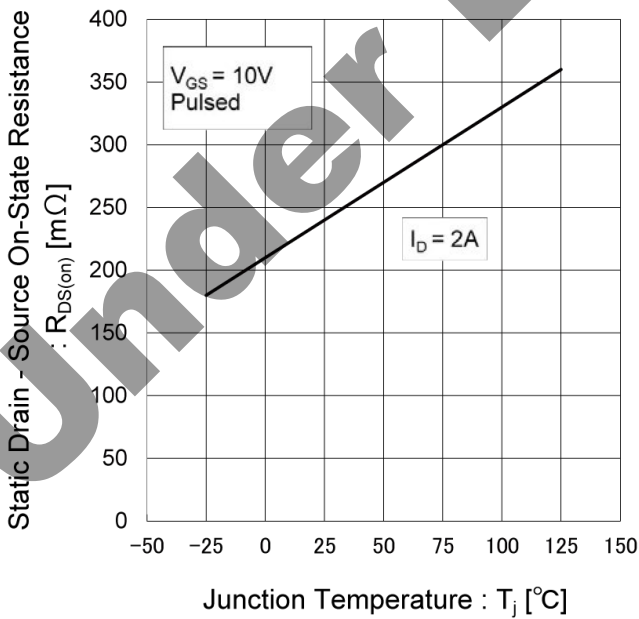


Fig.13 Static Drain - Source On - State Resistance vs. Junction Temperature





● Electrical characteristic curves <Tr1>

Fig.14 Static Drain - Source On - State Resistance vs. Drain Current (I)

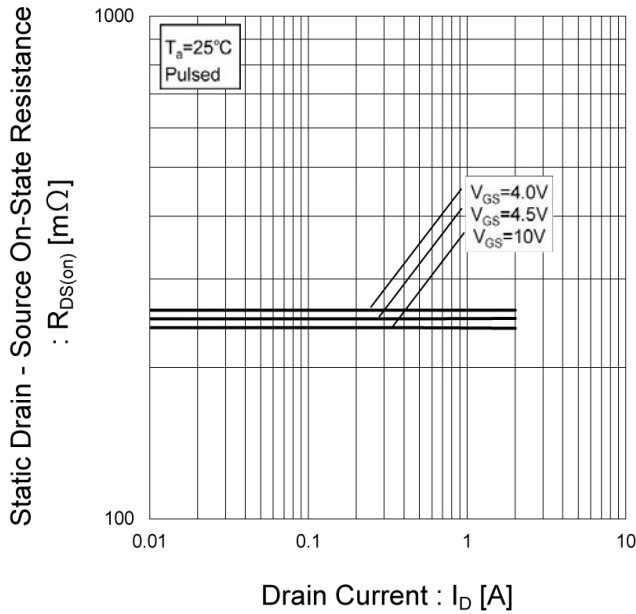


Fig.15 Static Drain - Source On - State Resistance vs. Drain Current (II)

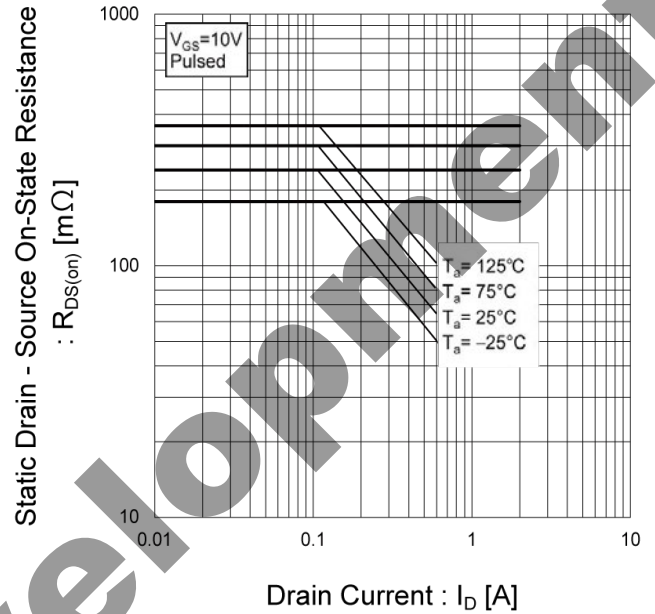


Fig.16 Static Drain - Source On - State Resistance vs. Drain Current (III)

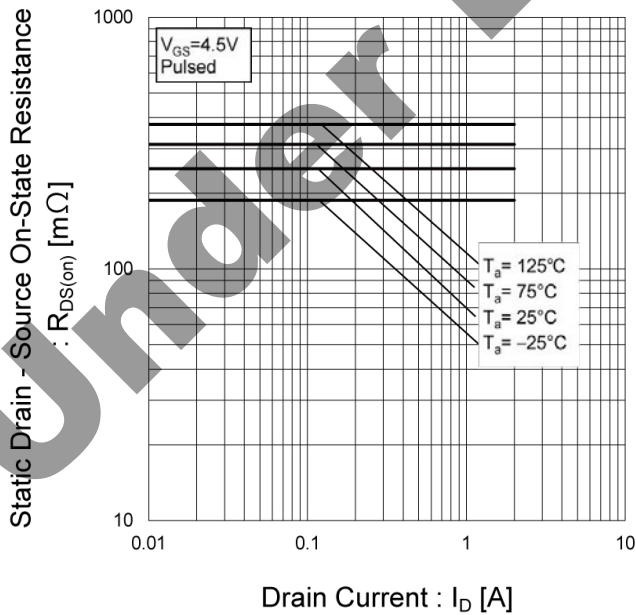
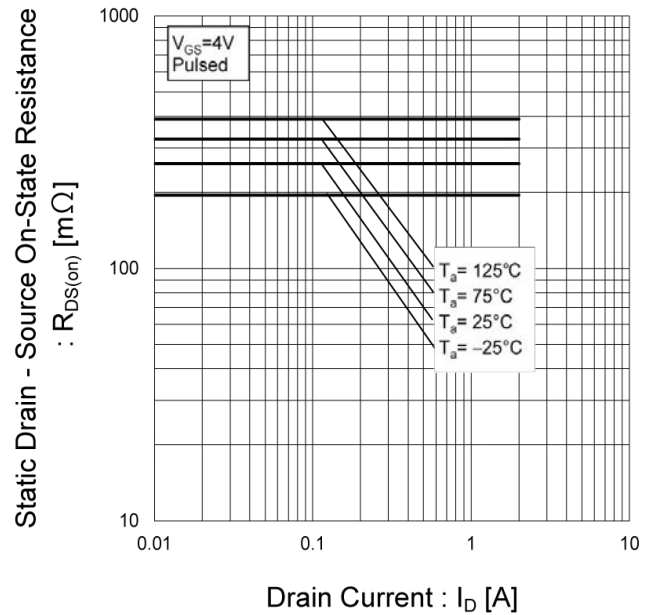


Fig.17 Static Drain - Source On - State Resistance vs. Drain Current (IV)



●Electrical characteristic curves <Tr1>

Fig.18 Typical Capacitance vs. Drain - Source Voltage

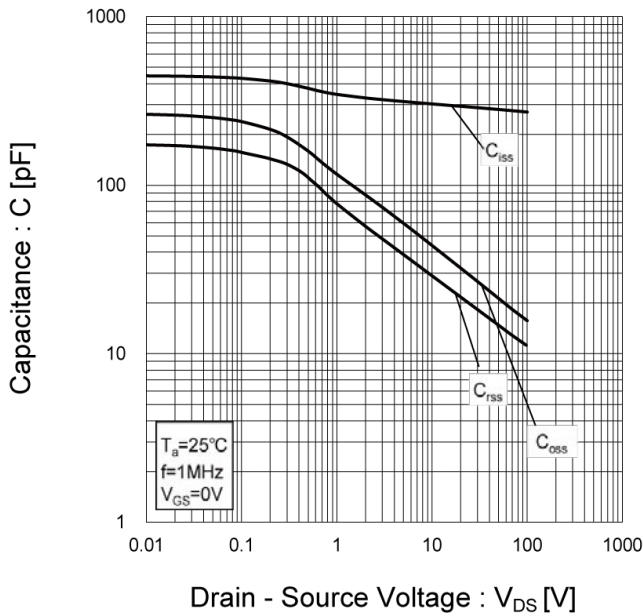


Fig.19 Switching Characteristics

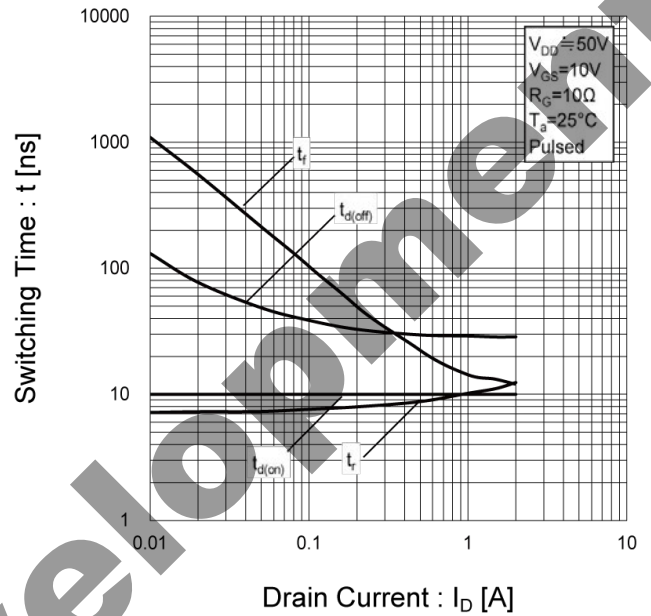


Fig.20 Dynamic Input Characteristics

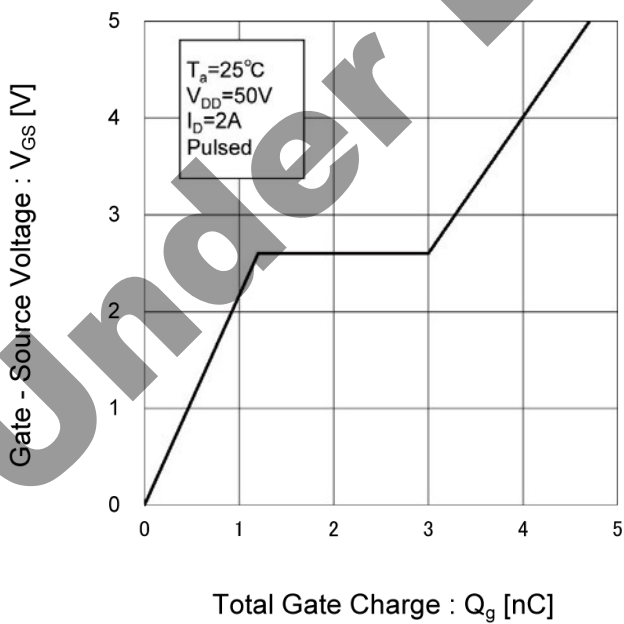
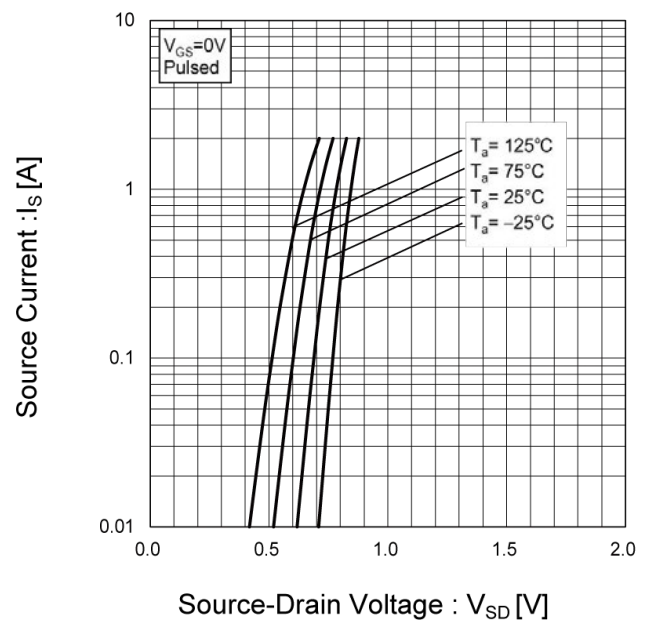


Fig.21 Source Current vs. Source Drain Voltage



● Electrical characteristic curves <Tr2>

Fig.1 Power Dissipation Derating Curve

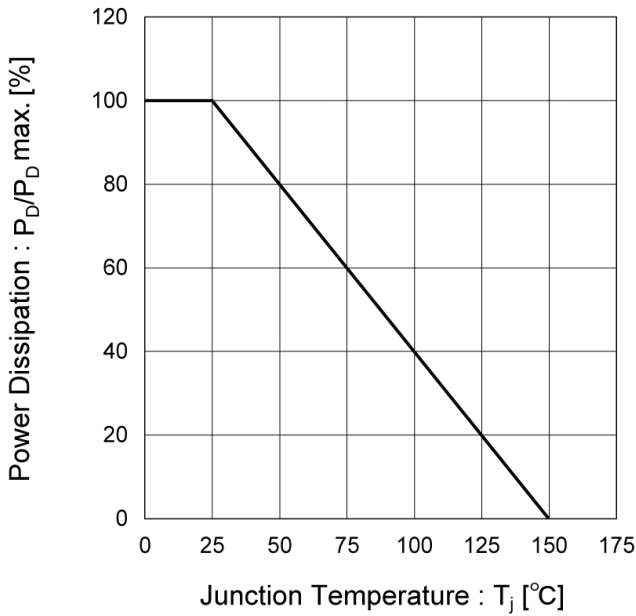


Fig.2 Maximum Safe Operating Area

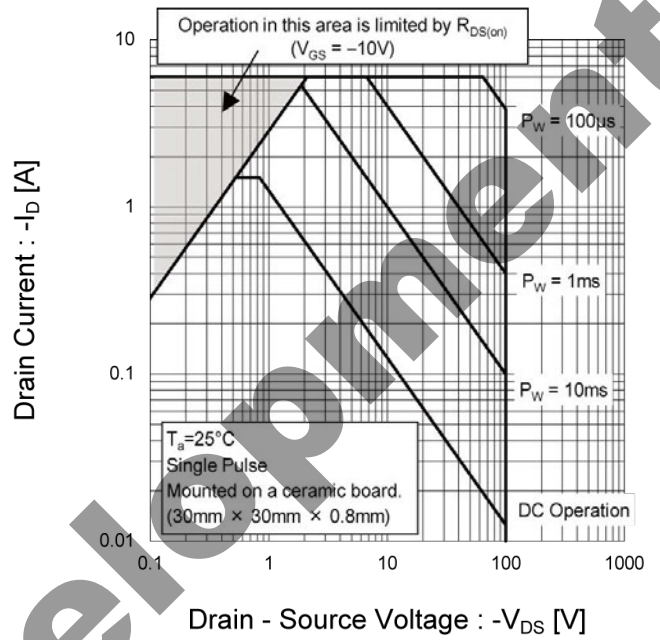


Fig.3 Normalized Transient Thermal Resistance vs. Pulse Width

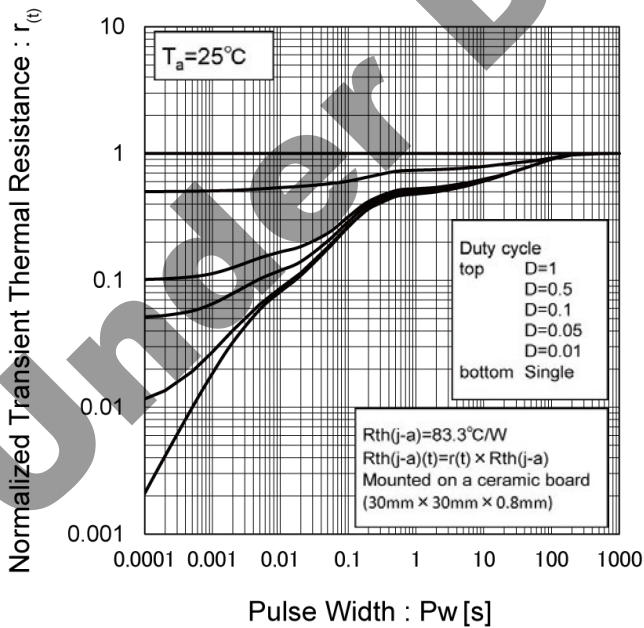
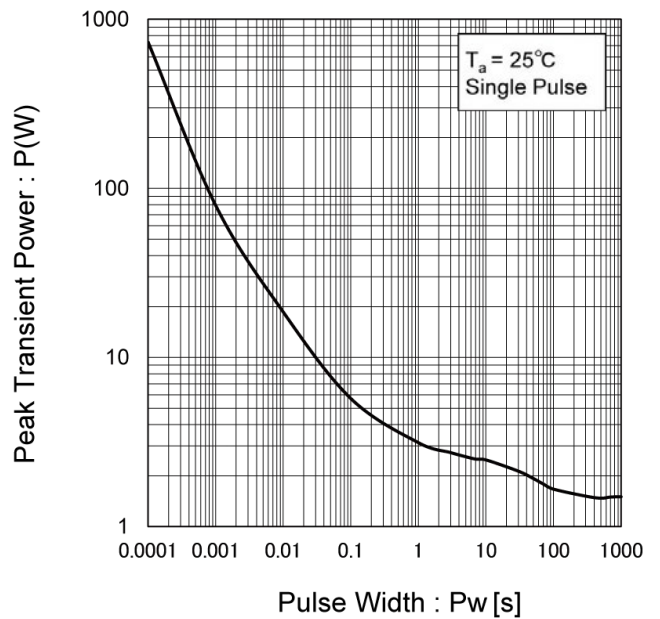


Fig.4 Single Pulse Maximum Power dissipation



●Electrical characteristic curves <Tr2>

Fig.5 Typical Output Characteristics(I)

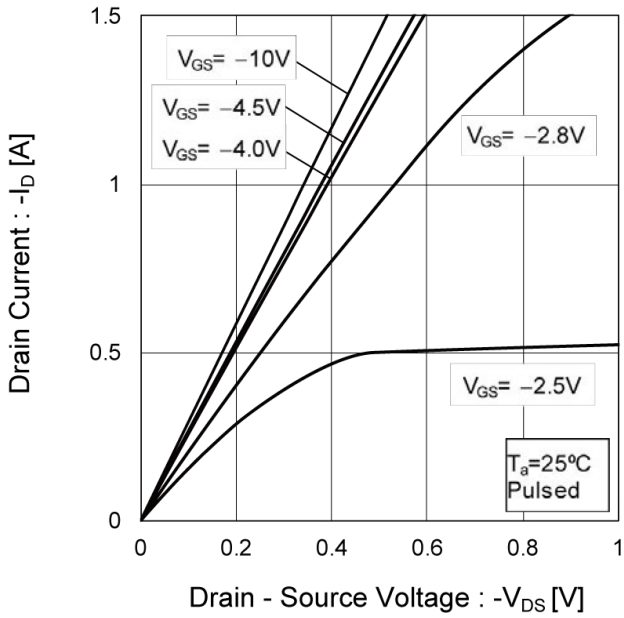


Fig.6 Typical Output Characteristics(II)

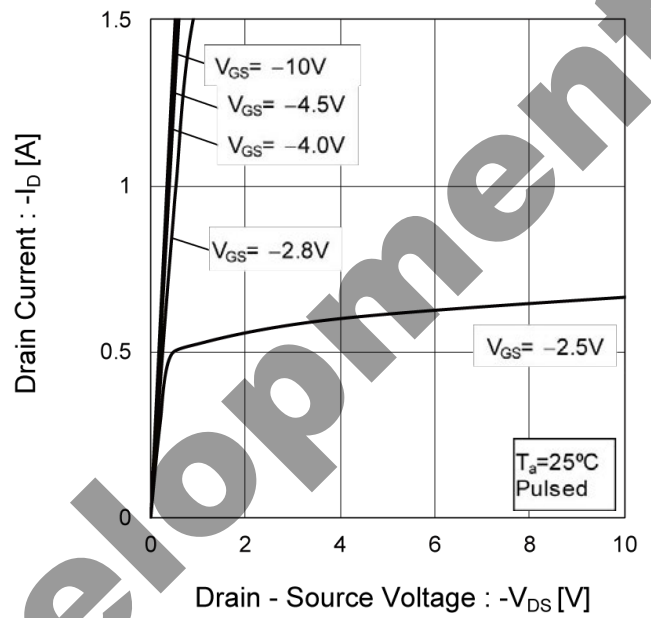
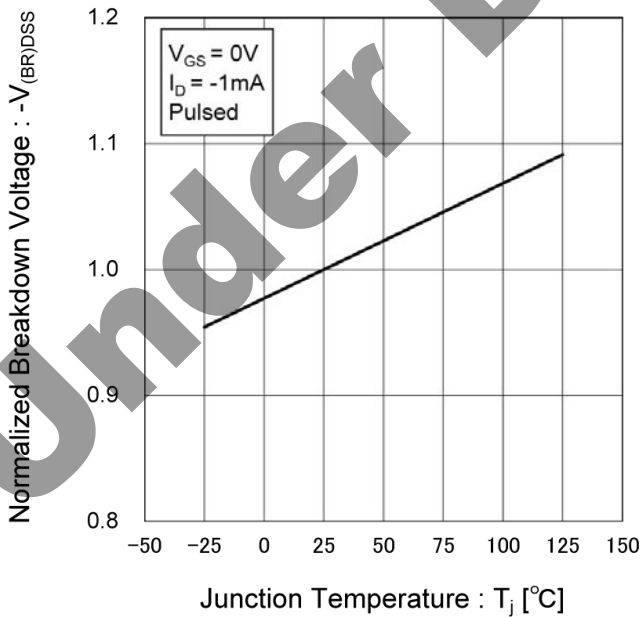


Fig.7 Breakdown Voltage vs. Junction Temperature



●Electrical characteristic curves <Tr2>

Fig.8 Typical Transfer Characteristics

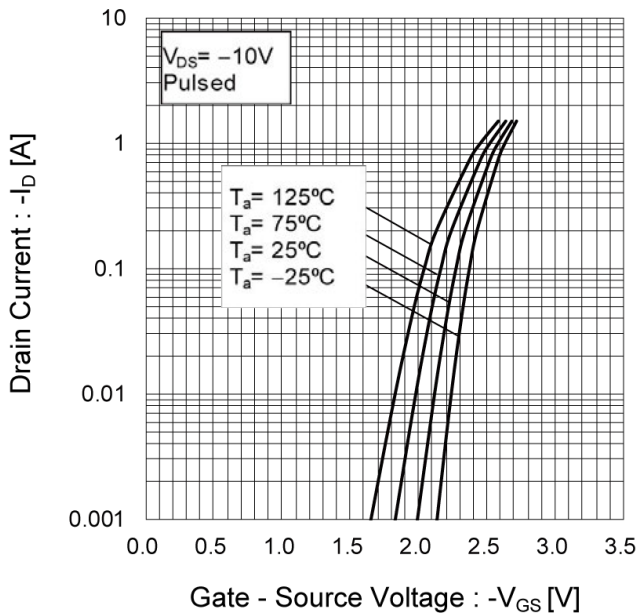


Fig.9 Gate Threshold Voltage vs. Junction Temperature

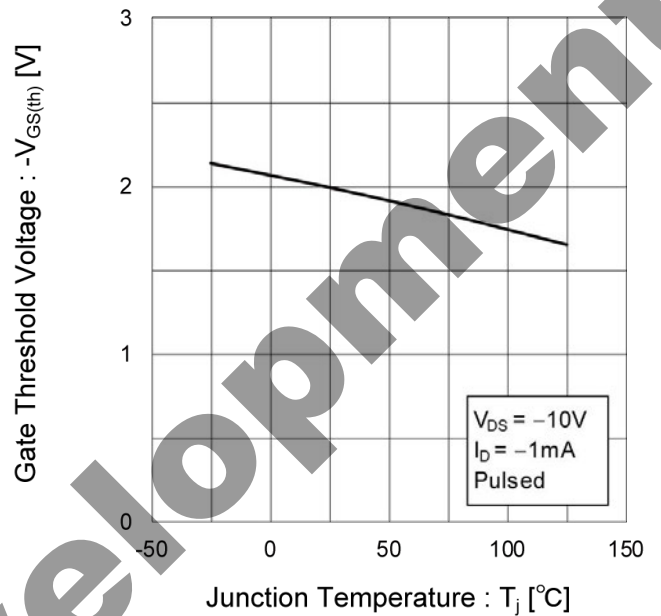
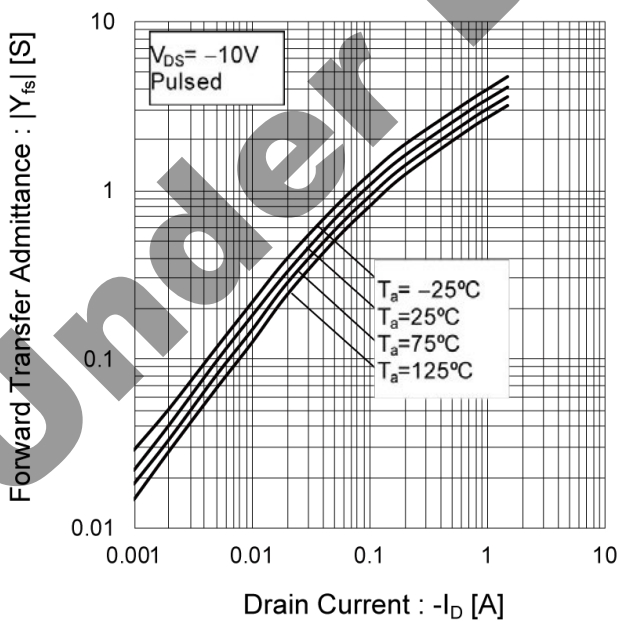


Fig.10 Forward Transfer Admittance vs. Drain Current



●Electrical characteristic curves <Tr2>

Fig.11 Drain Current Derating Curve

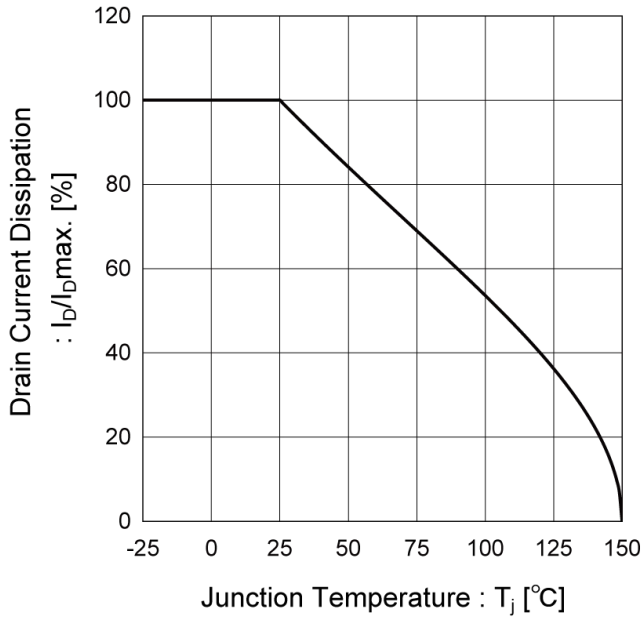


Fig.12 Static Drain - Source On - State Resistance vs. Gate Source Voltage

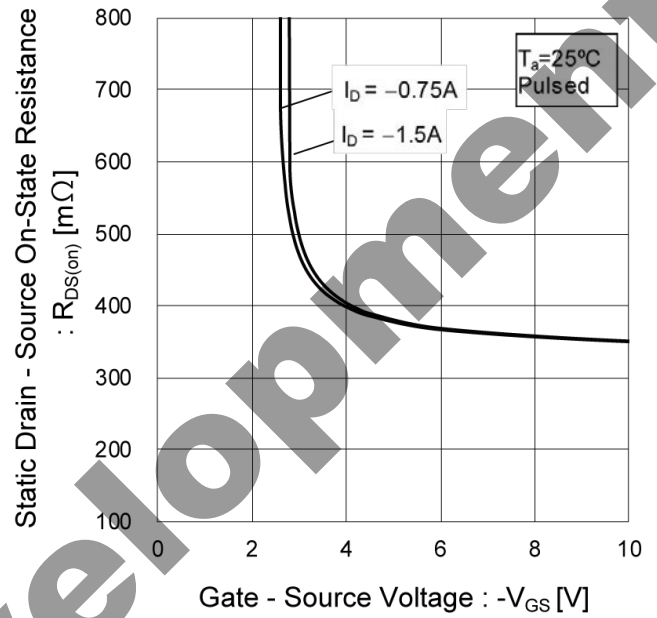
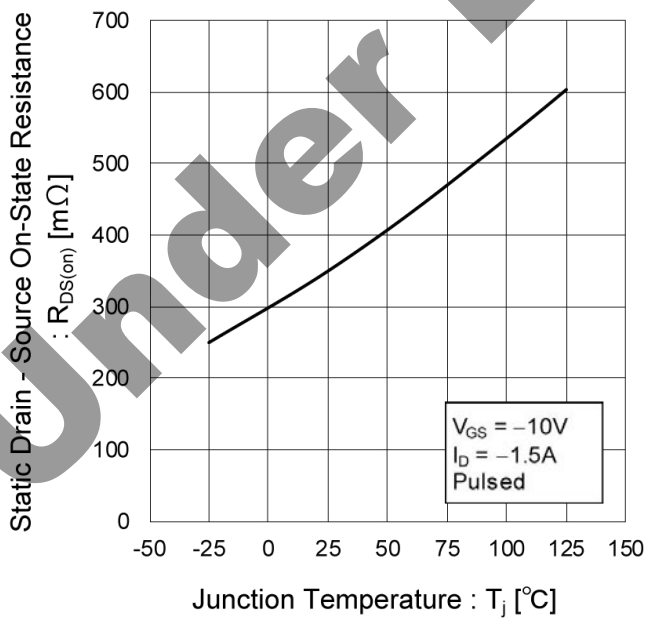


Fig.13 Static Drain - Source On - State Resistance vs. Junction Temperature



● Electrical characteristic curves <Tr2>

Fig.14 Static Drain - Source On - State Resistance vs. Drain Current (I)

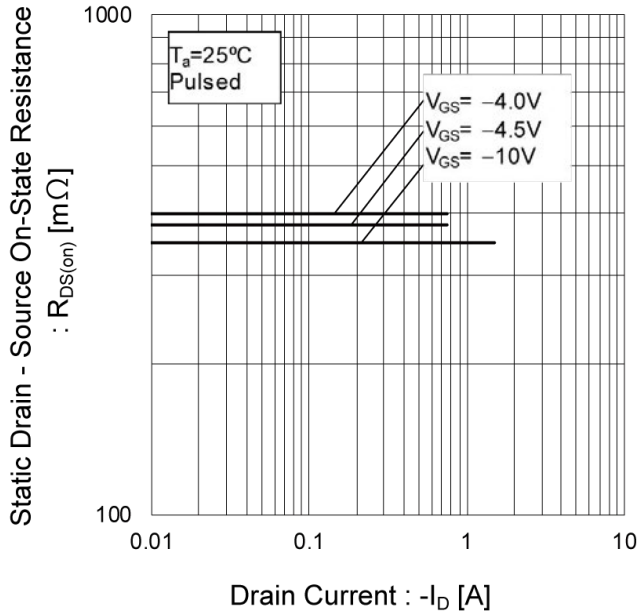


Fig.15 Static Drain - Source On - State Resistance vs. Drain Current (II)

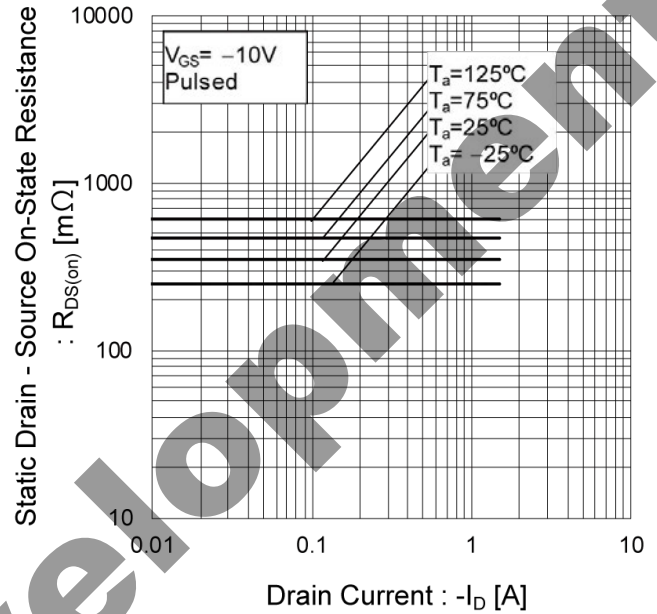


Fig.16 Static Drain - Source On - State Resistance vs. Drain Current (III)

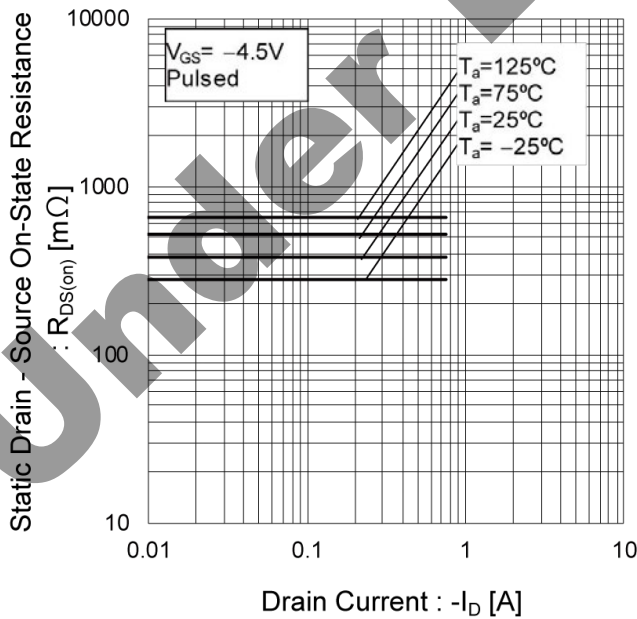
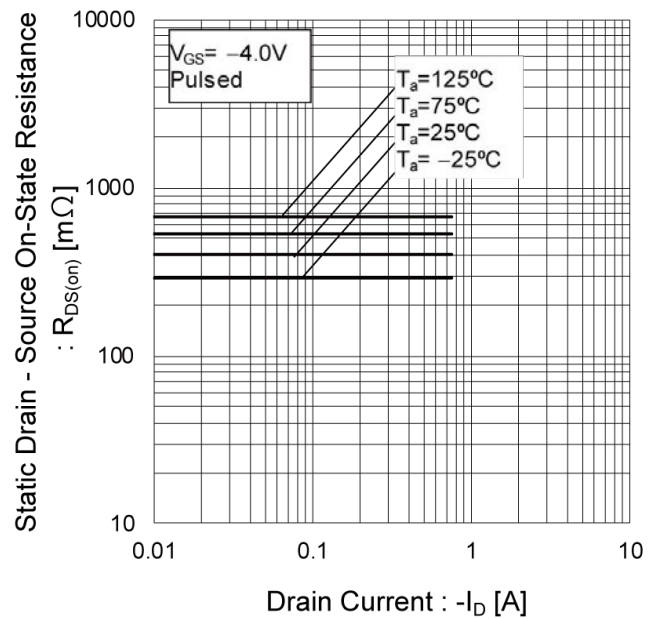


Fig.17 Static Drain - Source On - State Resistance vs. Drain Current (IV)



●Electrical characteristic curves <Tr2>

Fig.18 Typical Capacitance vs. Drain - Source Voltage

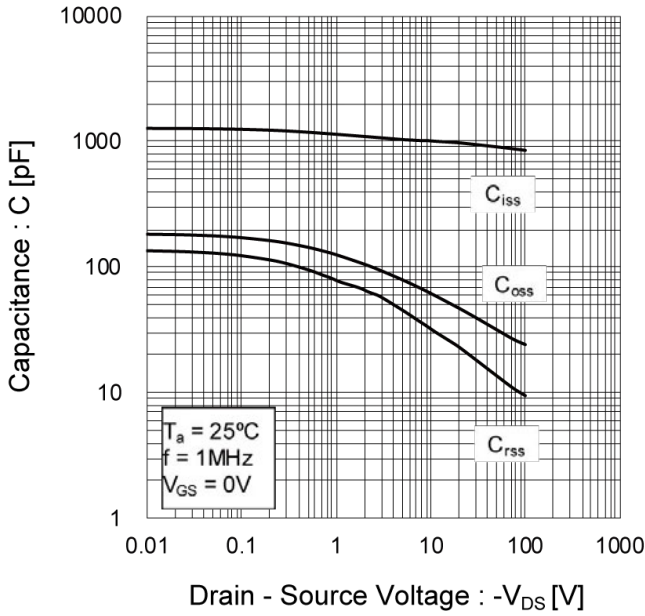


Fig.19 Switching Characteristics

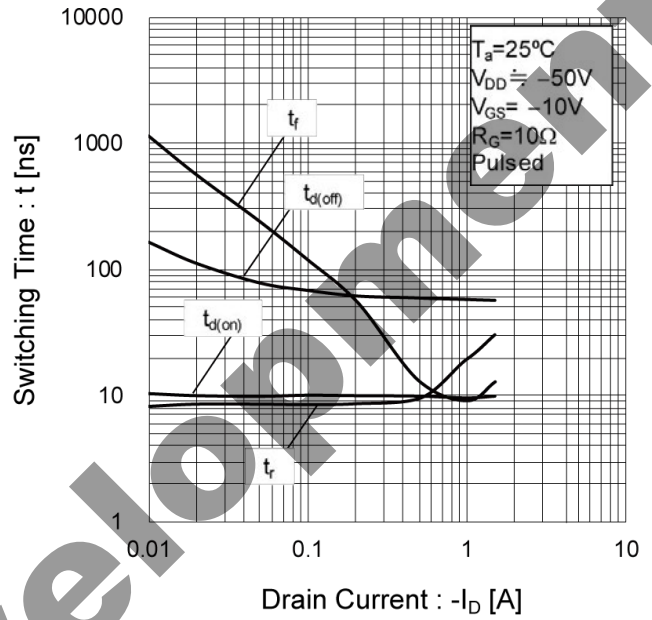


Fig.20 Dynamic Input Characteristics

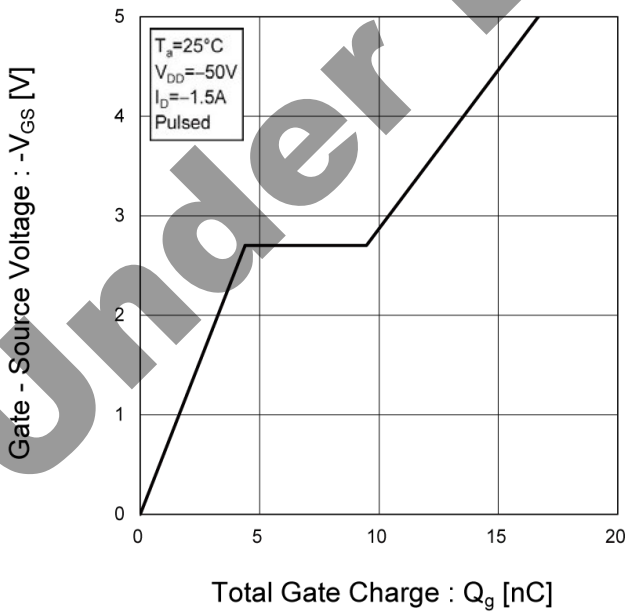
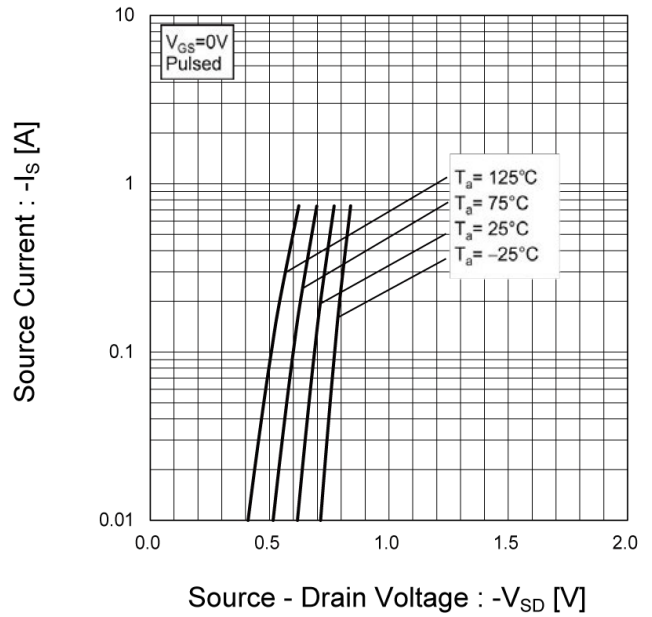


Fig.21 Source Current vs. Source Drain Voltage





● Measurement circuits <Tr1>

Fig.1-1 Switching Time Measurement Circuit

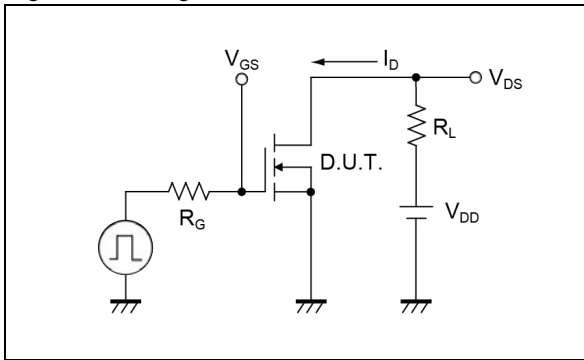


Fig.1-2 Switching Waveforms

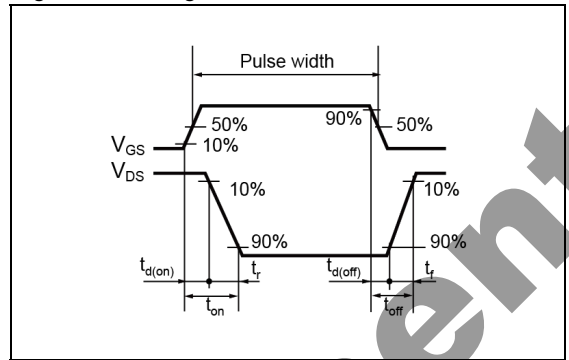


Fig.2-1 Gate Charge Measurement Circuit

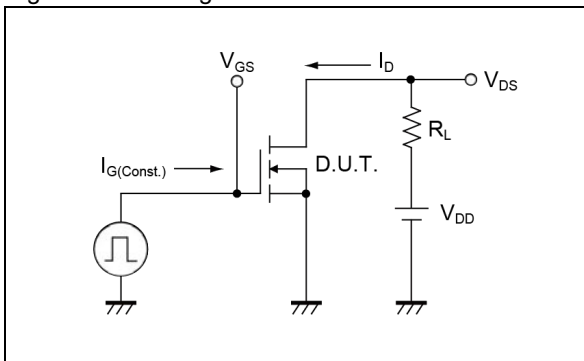
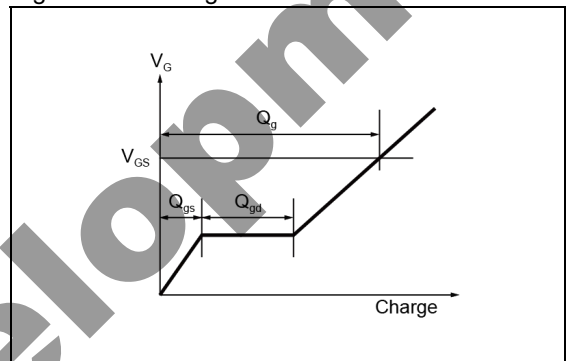


Fig.2-2 Gate Charge Waveform



Under Development

● Measurement circuits <Tr2>

Fig.3-1 Switching Time Measurement Circuit

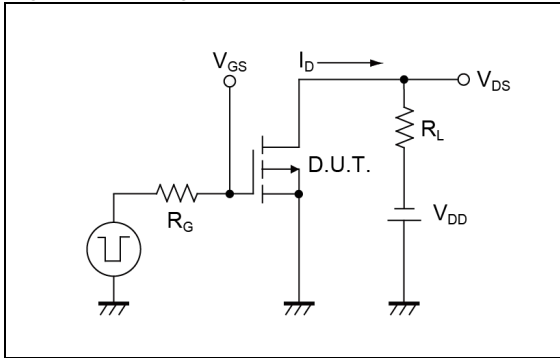


Fig.3-2 Switching Waveforms

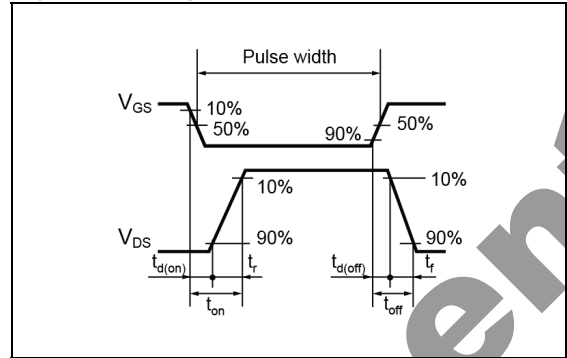


Fig.4-1 Gate Charge Measurement Circuit

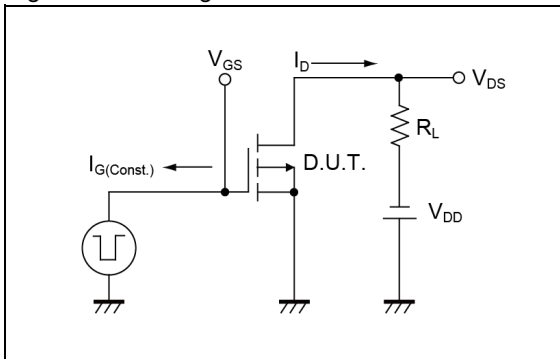
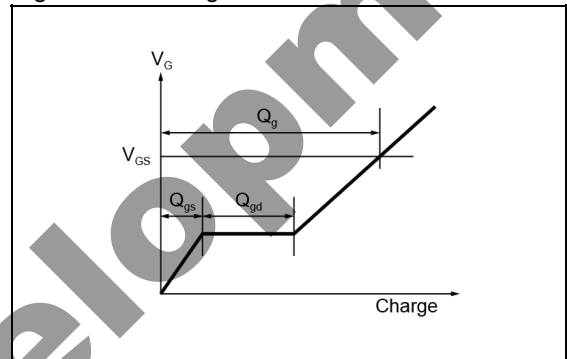


Fig.4-2 Gate Charge Waveform

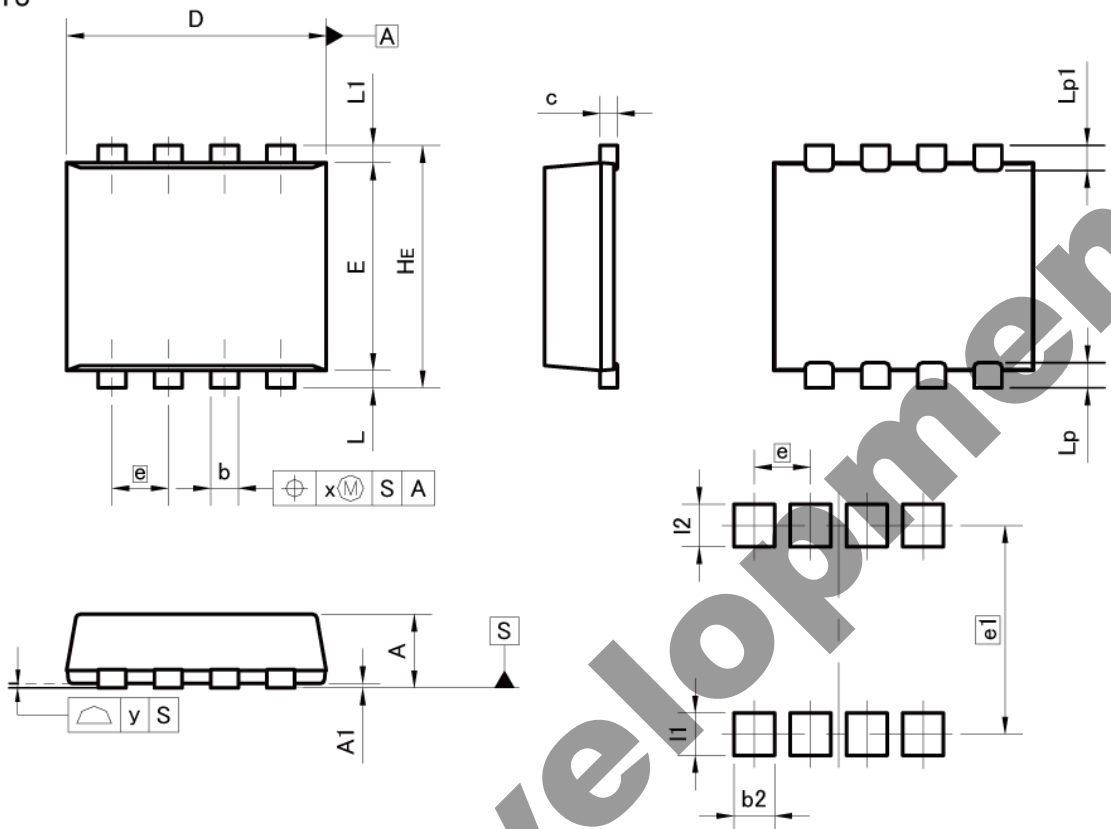


● Notice

This product might cause chip aging and breakdown under the large electrified environment. Please consider to design ESD protection circuit.

●Dimensions

TSMT8



Pattern of terminal position areas  
[Not a pattern of soldering pads]

DIM	MILIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	0.75	0.85	0.030	0.033
A1	0.00	0.05	0.000	0.002
b	0.27	0.37	0.011	0.015
c	0.12	0.22	0.005	0.009
D	2.90	3.10	0.114	0.122
E	2.30	2.50	0.091	0.098
e	0.65		0.026	
HE	2.70	2.90	0.106	0.114
L	0.10	0.30	0.004	0.012
L1	0.10	0.30	0.004	0.012
Lp	0.19	0.39	0.007	0.015
Lp1	0.19	0.39	0.007	0.015
x	-	0.10	-	0.004
y	-	0.10	-	0.004

DIM	MILIMETERS		INCHES	
	MIN	MAX	MIN	MAX
b2	-	0.47	-	0.019
e1	2.41		0.095	
l1	-	0.49	-	0.019
l2	-	0.49	-	0.019

Dimension in mm/inches

# Notice

## Precaution on using ROHM Products

1. If you intend to use our Products in devices requiring extremely high reliability (such as medical equipment <sup>(Note 1)</sup>, aircraft/spacecraft, nuclear power controllers, etc.) and whose malfunction or failure may cause loss of human life, bodily injury or serious damage to property ("Specific Applications"), please consult with the ROHM sales representative in advance. Unless otherwise agreed in writing by ROHM in advance, ROHM shall not be in any way responsible or liable for any damages, expenses or losses incurred by you or third parties arising from the use of any ROHM's Products for Specific Applications.

(Note1) Medical Equipment Classification of the Specific Applications

JAPAN	USA	EU	CHINA
CLASS III	CLASS III	CLASS II b	CLASS III
CLASS IV		CLASS III	

2. ROHM designs and manufactures its Products subject to strict quality control system. However, semiconductor products can fail or malfunction at a certain rate. Please be sure to implement, at your own responsibilities, adequate safety measures including but not limited to fail-safe design against the physical injury, damage to any property, which a failure or malfunction of our Products may cause. The following are examples of safety measures:
  - [a] Installation of protection circuits or other protective devices to improve system safety
  - [b] Installation of redundant circuits to reduce the impact of single or multiple circuit failure
3. Our Products are not designed under any special or extraordinary environments or conditions, as exemplified below. Accordingly, ROHM shall not be in any way responsible or liable for any damages, expenses or losses arising from the use of any ROHM's Products under any special or extraordinary environments or conditions. If you intend to use our Products under any special or extraordinary environments or conditions (as exemplified below), your independent verification and confirmation of product performance, reliability, etc. prior to use, must be necessary:
  - [a] Use of our Products in any types of liquid, including water, oils, chemicals, and organic solvents
  - [b] Use of our Products outdoors or in places where the Products are exposed to direct sunlight or dust
  - [c] Use of our Products in places where the Products are exposed to sea wind or corrosive gases, including Cl<sub>2</sub>, H<sub>2</sub>S, NH<sub>3</sub>, SO<sub>2</sub>, and NO<sub>2</sub>
  - [d] Use of our Products in places where the Products are exposed to static electricity or electromagnetic waves
  - [e] Use of our Products in proximity to heat-producing components, plastic cords, or other flammable items
  - [f] Sealing or coating our Products with resin or other coating materials
  - [g] Use of our Products without cleaning residue of flux (even if you use no-clean type fluxes, cleaning residue of flux is recommended); or Washing our Products by using water or water-soluble cleaning agents for cleaning residue after soldering
  - [h] Use of the Products in places subject to dew condensation
4. The Products are not subject to radiation-proof design.
5. Please verify and confirm characteristics of the final or mounted products in using the Products.
6. In particular, if a transient load (a large amount of load applied in a short period of time, such as pulse. is applied, confirmation of performance characteristics after on-board mounting is strongly recommended. Avoid applying power exceeding normal rated power; exceeding the power rating under steady-state loading condition may negatively affect product performance and reliability.
7. De-rate Power Dissipation depending on ambient temperature. When used in sealed area, confirm that it is the use in the range that does not exceed the maximum junction temperature.
8. Confirm that operation temperature is within the specified range described in the product specification.
9. ROHM shall not be in any way responsible or liable for failure induced under deviant condition from what is defined in this document.

## Precaution for Mounting / Circuit board design

1. When a highly active halogenous (chlorine, bromine, etc.) flux is used, the residue of flux may negatively affect product performance and reliability.
2. In principle, the reflow soldering method must be used on a surface-mount products, the flow soldering method must be used on a through hole mount products. If the flow soldering method is preferred on a surface-mount products, please consult with the ROHM representative in advance.

For details, please refer to ROHM Mounting specification

### Precautions Regarding Application Examples and External Circuits

1. If change is made to the constant of an external circuit, please allow a sufficient margin considering variations of the characteristics of the Products and external components, including transient characteristics, as well as static characteristics.
2. You agree that application notes, reference designs, and associated data and information contained in this document are presented only as guidance for Products use. Therefore, in case you use such information, you are solely responsible for it and you must exercise your own independent verification and judgment in the use of such information contained in this document. ROHM shall not be in any way responsible or liable for any damages, expenses or losses incurred by you or third parties arising from the use of such information.

### Precaution for Electrostatic

This Product is electrostatic sensitive product, which may be damaged due to electrostatic discharge. Please take proper caution in your manufacturing process and storage so that voltage exceeding the Products maximum rating will not be applied to Products. Please take special care under dry condition (e.g. Grounding of human body / equipment / solder iron, isolation from charged objects, setting of ionizer, friction prevention and temperature / humidity control).

### Precaution for Storage / Transportation

1. Product performance and soldered connections may deteriorate if the Products are stored in the places where:
  - [a] the Products are exposed to sea winds or corrosive gases, including Cl<sub>2</sub>, H<sub>2</sub>S, NH<sub>3</sub>, SO<sub>2</sub>, and NO<sub>2</sub>
  - [b] the temperature or humidity exceeds those recommended by ROHM
  - [c] the Products are exposed to direct sunshine or condensation
  - [d] the Products are exposed to high Electrostatic
2. Even under ROHM recommended storage condition, solderability of products out of recommended storage time period may be degraded. It is strongly recommended to confirm solderability before using Products of which storage time is exceeding the recommended storage time period.
3. Store / transport cartons in the correct direction, which is indicated on a carton with a symbol. Otherwise bent leads may occur due to excessive stress applied when dropping of a carton.
4. Use Products within the specified time after opening a humidity barrier bag. Baking is required before using Products of which storage time is exceeding the recommended storage time period.

### Precaution for Product Label

A two-dimensional barcode printed on ROHM Products label is for ROHM's internal use only.

### Precaution for Disposition

When disposing Products please dispose them properly using an authorized industry waste company.

### Precaution for Foreign Exchange and Foreign Trade act

Since concerned goods might be fallen under listed items of export control prescribed by Foreign exchange and Foreign trade act, please consult with ROHM in case of export.

### Precaution Regarding Intellectual Property Rights

1. All information and data including but not limited to application example contained in this document is for reference only. ROHM does not warrant that foregoing information or data will not infringe any intellectual property rights or any other rights of any third party regarding such information or data.
2. ROHM shall not have any obligations where the claims, actions or demands arising from the combination of the Products with other articles such as components, circuits, systems or external equipment (including software).
3. No license, expressly or implied, is granted hereby under any intellectual property rights or other rights of ROHM or any third parties with respect to the Products or the information contained in this document. Provided, however, that ROHM will not assert its intellectual property rights or other rights against you or your customers to the extent necessary to manufacture or sell products containing the Products, subject to the terms and conditions herein.

### Other Precaution

1. This document may not be reprinted or reproduced, in whole or in part, without prior written consent of ROHM.
2. The Products may not be disassembled, converted, modified, reproduced or otherwise changed without prior written consent of ROHM.
3. In no event shall you use in any way whatsoever the Products and the related technical information contained in the Products or this document for any military purposes, including but not limited to, the development of mass-destruction weapons.
4. The proper names of companies or products described in this document are trademarks or registered trademarks of ROHM, its affiliated companies or third parties.

**General Precaution**

1. Before you use our Products, you are requested to carefully read this document and fully understand its contents. ROHM shall not be in any way responsible or liable for failure, malfunction or accident arising from the use of any ROHM's Products against warning, caution or note contained in this document.
2. All information contained in this document is current as of the issuing date and subject to change without any prior notice. Before purchasing or using ROHM's Products, please confirm the latest information with a ROHM sales representative.
3. The information contained in this document is provided on an "as is" basis and ROHM does not warrant that all information contained in this document is accurate and/or error-free. ROHM shall not be in any way responsible or liable for any damages, expenses or losses incurred by you or third parties resulting from inaccuracy or errors of or concerning such information.

Under Development